Precision 1:6 LVDS Fanout Buffer



Data Sheet

November 2012

Ordering Information

ZL40216LDG1 32 Pin QFN Trays
ZL40216LDF1 32 Pin QFN Tape and Reel

Matte Tin

Package Size: 5 x 5 mm -40°C to +85°C

Features

Inputs/Outputs

- · Accepts differential or single-ended input
 - LVPECL, LVDS, CML, HCSL, LVCMOS
- · Six precision LVDS outputs
- · Operating frequency up to 750 MHz

Power

- Option for 2.5 V or 3.3 V power supply
- · Current consumption of 93 mA
- On-chip Low Drop Out (LDO) Regulator for superior power supply noise rejection

Performance

Ultra low additive jitter of 104 fs RMS

Applications

- General purpose clock distribution
- · Low jitter clock trees
- Logic translation
- Clock and data signal restoration
- Wired communications: OTN, SONET/SDH, GE, 10 GE, FC and 10G FC
- · Wireless communications
- High performance micro-processor clock distribution

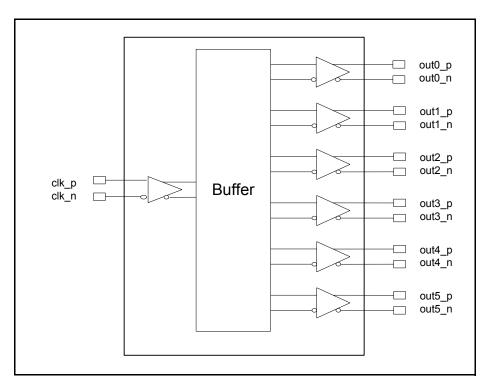


Figure 1 - Functional Block Diagram

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1.0 Package Description

The device is packaged in a 32 pin QFN

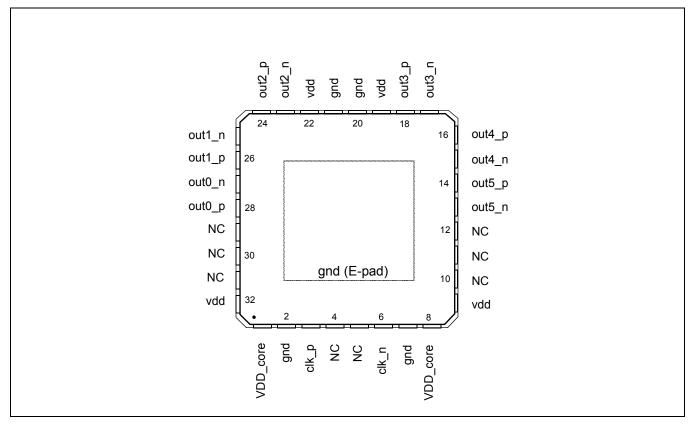


Figure 2 - Pin Connections

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2.0 Pin Description

Pin#	Name	Description
3, 6	clk_p, clk_n,	Differential Input (Analog Input). Differential input signals.
28, 27,	out0_p, out0_n	Differential Output (Analog Output). Differential outputs.
26, 25,	out1_p, out1_n	
24, 23,	out2_p, out2_n	
18, 17,	out3_p, out3_n	
16, 15,	out4_p, out4_n	
14, 13,	out5_p, out5_n	
9, 19,	vdd	Positive Supply Voltage. 2.5 V _{DC} or 3.3 V _{DC} nominal.
22, 32		
1, 8	vdd_core	Positive Supply Voltage. 2.5 V _{DC} or 3.3 V _{DC} nominal.
2, 7,	gnd	Ground. 0 V.
20, 21		
4, 5	NC	No Connection. Leave unconnected.
10, 11,		
12,		
29,30,		
31		

3.0 Functional Description

The ZL40216 is an LVDS clock fanout buffer with six identical output clock drivers capable of operating at frequencies up to 750MHz.

Inputs to the ZL40216 are externally terminated to allow use of precision termination components and to allow full flexibility of input termination. The ZL40216 can accept DC or AC coupled LVPECL, LVDS, CML or HCSL input signals; single ended input signals can also be accepted. A pin compatible device with internal termination is also available.

The ZL40216 is designed to fan out low-jitter reference clocks for wired or optical communications applications while adding minimal jitter to the clock signal. An internal linear power supply regulator and bulk capacitors minimize additive jitter due to power supply noise. The device operates from 2.5V+/-5% or 3.3V+/-5% supply. Its operation is guaranteed over the industrial temperature range -40°C to +85°C.

The device block diagram is shown in Figure 1; its operation is described in the following sections.

3.1 Clock Inputs

The ZL40216 is adaptable to support different types of differential and singled-ened input signals depending on the passive components used in the input termination. The application diagrams in the following figures allow the ZL40216 to accept LVPECL, LVDS, CML, HCSL and single-ended inputs.

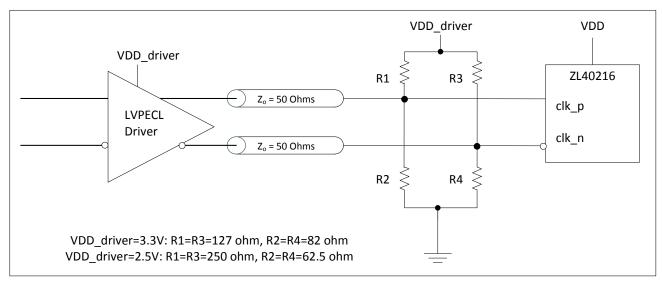


Figure 3 - LVPECL Input DC Coupled Thevenin Equivalent

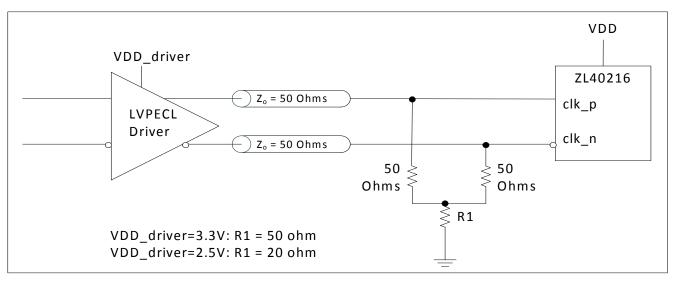


Figure 4 - LVPECL Input DC Coupled Parallel Termination

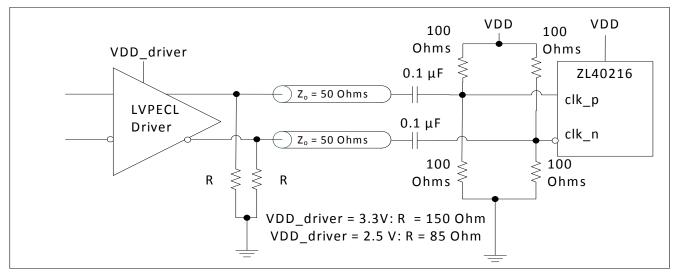


Figure 5 - LVPECL Input AC Coupled

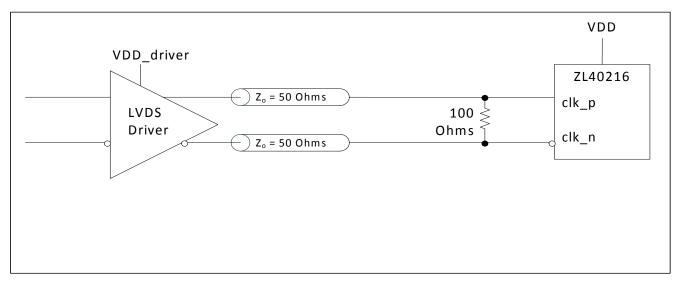


Figure 6 - LVDS Input DC Coupled

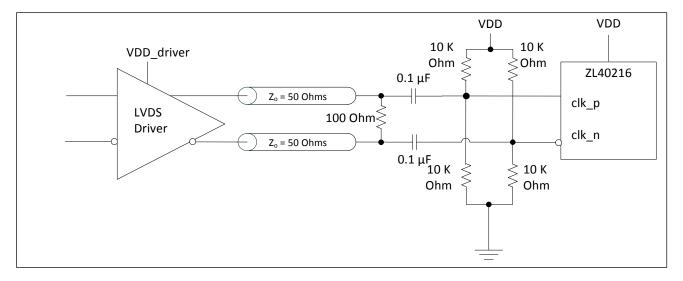


Figure 7 - LVDS Input AC Coupled

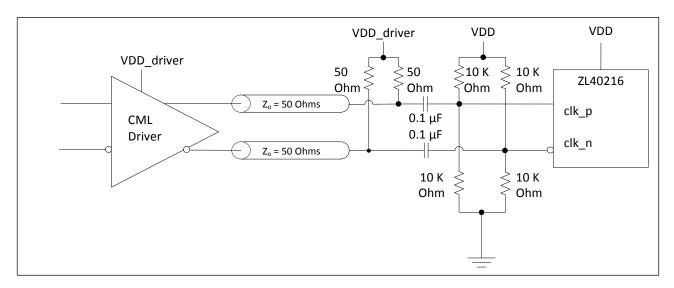


Figure 8 - CML Input AC Coupled

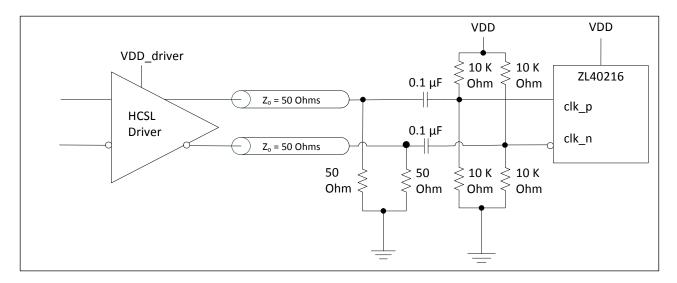


Figure 9 - HCSL Input AC Coupled

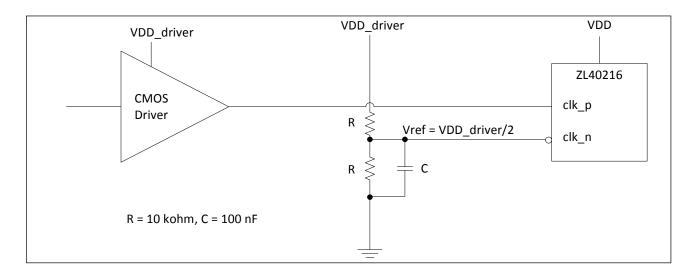


Figure 10 - CMOS Input DC Coupled Referenced to VDD/2

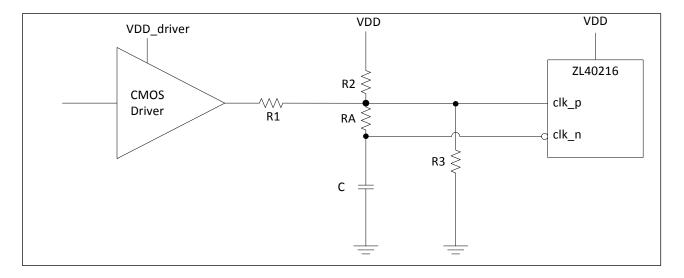


Figure 11 - CMOS Input DC Coupled Referenced to Ground

VDD_driver	R1 (kΩ)	R2 (kΩ)	R3 (kΩ)	RA (kΩ)	C (pF)
1.5	1.25	3.075	open	10	10
1.8	1	3.8	open	10	10
2.5	0.33	4.2	open	10	10
3.3	0.75	open	4.2	10	10

Table 1 - Component Values for Single Ended Input Reference to Ground

^{*} For frequencies below 100 MHz, increase C to avoid signal integrity issues.

3.2 Clock Outputs

LVDS has lower signal swing than LVPECL which results in a low power consumption. A simplified diagram for the LVDS output stage is shown in Figure 12.

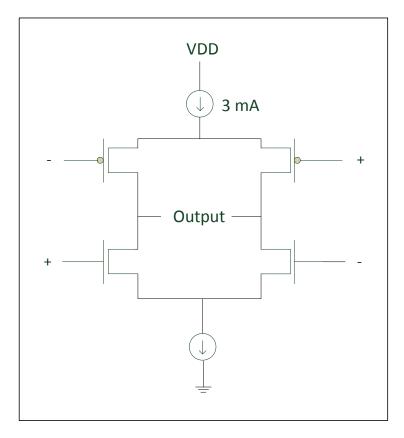


Figure 12 - Simplified LVDS Output Driver

The methods to terminate the ZL40216 drivers are shown in the following figures.

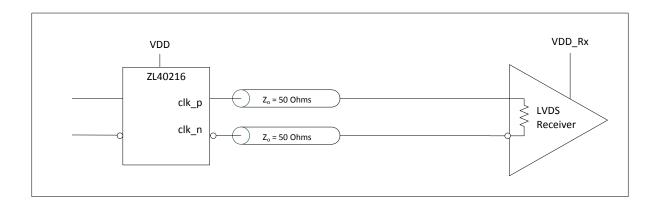


Figure 13 - LVDS DC Coupled Termination (Internal Receiver Termination)

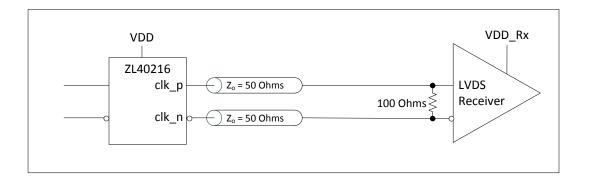


Figure 14 - LVDS DC Coupled Termination (External Receiver Termination)

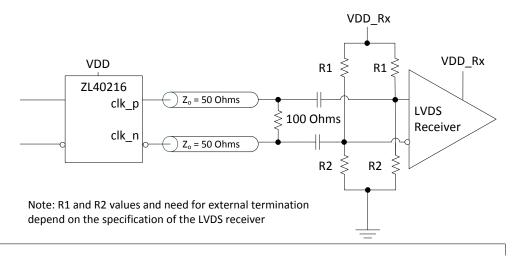


Figure 15 - LVDS AC Coupled Termination

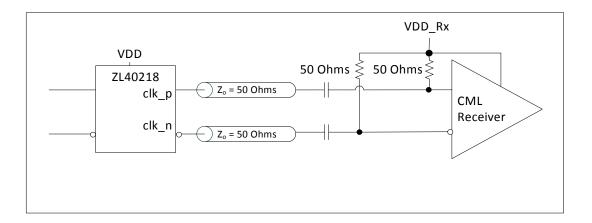


Figure 16 - LVDS AC Output Termination for CML Inputs

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3.3 Device Additive Jitter

The ZL40216 clock fanout buffer is not intended to filter clock jitter. The jitter performance of this type of device is characterized by its additive jitter. Additive jitter is the jitter the device would add to a hypothetical jitter-free clock as it passes through the device. The additive jitter of the ZL40216 is random and as such it is not correlated to the jitter of the input clock signal.

The square of the resultant random RMS jitter at the output of the ZL40216 is equal to the sum of the squares of the various random RMS jitter sources including: input clock jitter; additive jitter of the buffer; and additive jitter due to power supply noise. There may be additional deterministic jitter sources, but they are not shown in Figure 17.

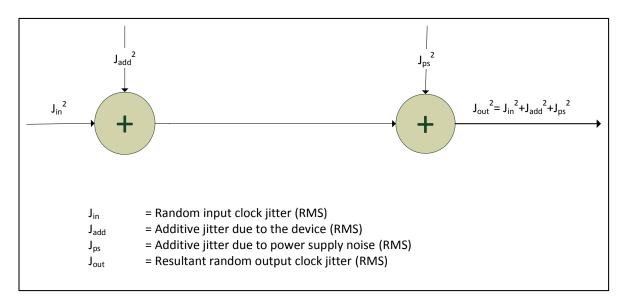


Figure 17 - Additive Jitter

3.4 Power Supply

This device operates employing either a 2.5V supply or 3.3V supply.

3.4.1 Sensitivity to power supply noise

Power supply noise from sources such as switching power supplies and high-power digital components such as FPGAs can induce additive jitter on clock buffer outputs. The ZL40216 is equipped with an on-chip linear power regulator and on-chip bulk capacitors to minimize additive jitter due to power supply noise. The on-chip measures in combination with the simple recommended power supply filtering and PCB layout are effective at minimizing additive jitter from power supply noise.

3.4.2 Power supply filtering

Jitter levels may increase when noise is present on the power pins. For optimal jitter performance, the device should be isolated from the power planes connected to its power supply pins as shown in Figure 18.

- 10 μF capacitors should be size 0603 or size 0805 X5R or X7R ceramic, 6.3 V minimum rating
- 0.1 µF capacitors should be size 0402 X5R ceramic, 6.3 V minimum rating
- · Capacitors should be placed next to the connected device power pins
- A 0.15 ohm resistor is recommended

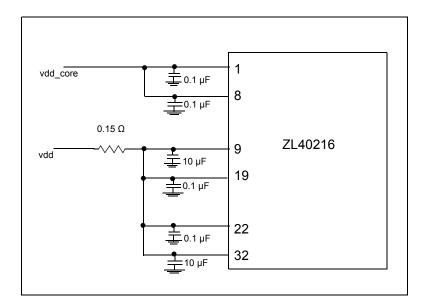


Figure 18 - Decoupling Connections for Power Pins

3.4.3 PCB layout considerations

The power nets in Figure 18 can be implemented either as a plane island or routed power topology without changing the overall jitter performance of the device.

4.0 **AC and DC Electrical Characteristics**

Absolute Maximum Ratings*

	Parameter	Sym.	Min.	Max.	Units
1	Supply voltage	V_{DD_R}	-0.5	4.6	V
2	Voltage on any digital pin	V _{PIN}	-0.5	V_{DD}	V
3	Soldering temperature	Т		260	°C
4	Storage temperature	T _{ST}	-55	125	°C
5	Junction temperature	Tj		125	°C
6	Voltage on input pin	V _{input}		V_{DD}	V
7	Input capacitance each pin	C _p		500	fF

^{*} Exceeding these values may cause permanent damage. Functional operation under these conditions is not implied.
* Voltages are with respect to ground (GND) unless otherwise stated

Recommended Operating Conditions*

	Characteristics	Sym.	Min.	Тур.	Max.	Units
1	Supply voltage 2.5 V mode	V_{DD25}	2.375	2.5	2.625	V
2	Supply voltage 3.3 V mode	V_{DD33}	3.135	3.3	3.465	V
3	Operating temperature	T _A	-40	25	85	°C

^{*} Voltages are with respect to ground (GND) unless otherwise stated

DC Electrical Characteristics - Current Consumption

	Characteristics	Sym.	Min.	Тур.	Max.	Units	Notes
1	Supply current LVDS drivers - loaded (all outputs are active)	I _{dd_load}		93		mA	

DC Electrical Characteristics - Inputs and outputs - for 2.5/3.3 V supply

	Characteristics	Sym.	Min.	Тур.	Max.	Units	Notes
1	Differential input common mode	V _{ICM}	1.1		1.6	V	for 2.5 V
2	Differential input common mode	V _{ICM}	1.1		2.0	V	for 3.3 V
3	Differential input voltage	V_{ID}	0.25		1	V	
4	LVDS output differential voltage*	V _{OD}	0.25	0.30	0.40	V	
5	LVDS Common Mode voltage	V_{CM}	1.1	1.25	1.375	V	

^{*} The VOD parameter was measured between 125 and 750 MHz



Figure 19 - Differential Voltage Parameter

AC Electrical Characteristics* - Inputs and Outputs (see Figure 20) - for 2.5/3.3 V supply.

	Characteristics	Sym.	Min.	Тур.	Max.	Units	Notes
1	Maximum Operating Frequency	1/t _p			750	MHz	
2	input to output clock propagation delay	t _{pd}	0	1	2	ns	
3	output to output skew	t _{out2out}		80	150	ps	
4	part to part output skew	t _{part2part}		120	300	ps	
5	Output clock Duty Cycle degradation	t _{PWH} / t _{PWL}	-5	0	5	Percent	
6	LVDS Output slew rate	r _{SL}	0.55			V/ns	

^{*} Supply voltage and operating temperature are as per Recommended Operating Conditions

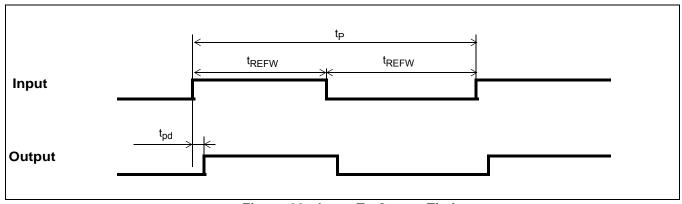


Figure 20 - Input To Output Timing

5.0 Performance Characterization

Additive Jitter at 2.5 V*

	Output Frequency (MHz)	Jitter Measurement Filter	Typical RMS (fs)	Notes
1	125	12 kHz - 20 MHz	148	
2	212.5	12 kHz - 20 MHz	152	
3	311.04	12 kHz - 20 MHz	121	
4	425	12 kHz - 20 MHz	115	
5	500	12 kHz - 20 MHz	107	
6	622.08	12 kHz - 20 MHz	107	
7	750	12 kHz - 20 MHz	105	

^{*}The values in this table were taken with an approximate slew rate of 0.8 V/ns

Additive Jitter at 3.3 V*

	Output Frequency (MHz)	Jitter Measurement Filter	Typical RMS (fs)	Notes
1	125	12 kHz - 20 MHz	150	
2	212.5	12 kHz - 20 MHz	138	
3	311.04	12 kHz - 20 MHz	120	
4	425	12 kHz - 20 MHz	115	
5	500	12 kHz - 20 MHz	107	
6	622.08	12 kHz - 20 MHz	106	
7	750	12 kHz - 20 MHz	104	

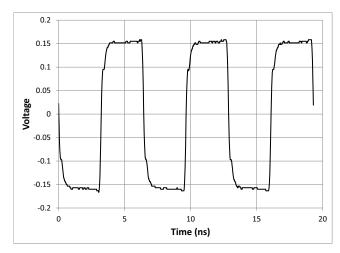
^{*}The values in this table were taken with an approximate slew rate of 0.8 V/ns.

Additive jitter from a power supply tone*

Carrier frequency	Parameter	Typical	Units	Notes
125	25 mV at 100 kHz	24	fs RMS	
750	25 mV at 100 kHz	23	fs RMS	

^{*} The values in this table are the additive periodic jitter caused by an interfering tone typically caused by a switching power supply. For this test, measurements were taken over the full temperature and voltage range for V_{DD} = 3.3 V. The magnitude of the interfering tone is measured at the DUT.

6.0 Typical Behavior



0.35

0.34

0.33

0.32

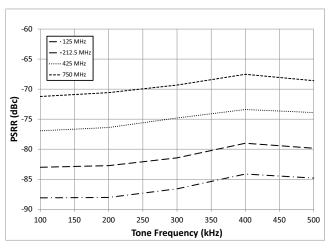
0.31

0.3

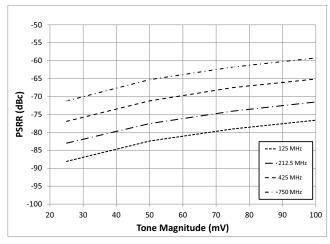
0 100 200 300 400 500 600 700 800

Frequency (MHz)

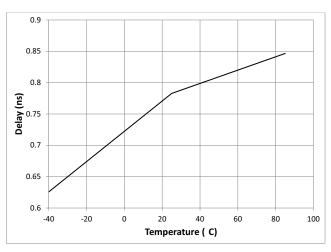
Typical Waveform at 155.52 MHz



 $V_{\mbox{\scriptsize OD}}$ vs Frequency



Power Supply Tone Frequency versus PSRR



Power Supply Tone Magnitude versus PSRR

Propogation Delay versus Temperature

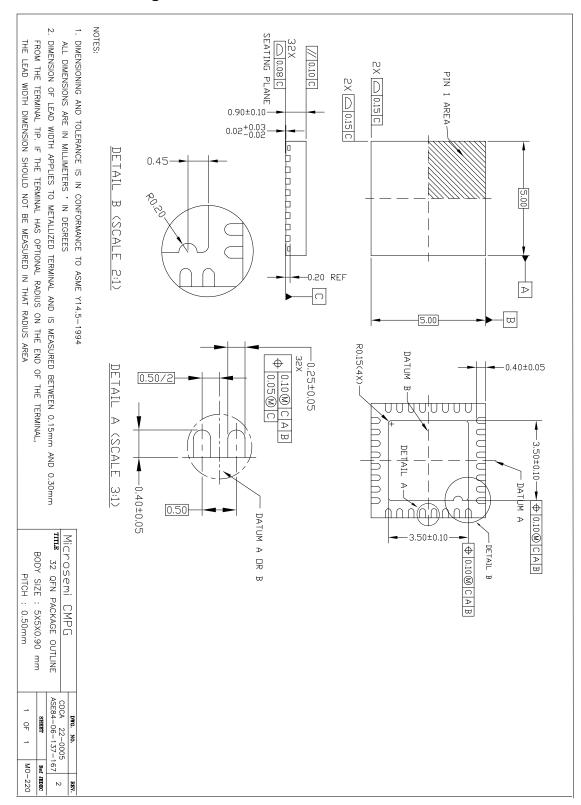
Note: This is for a single device. For more details, see the characterization section.

7.0 Package Characteristics

Thermal Data

Parameter	Symbol	Test Condition	Value	Unit
Junction to Ambient Thermal Resistance	Θ_{JA}	Still Air	37.4	°C/W
		1 m/s	33.1	
		2 m/s	31.5	
Junction to Case Thermal Resistance	Θ _{JC}		24.4	°C/W
Junction to Board Thermal Resistance	Θ _{JB}		19.5	°C/W
Maximum Junction Temperature*	T _{jmax}		125	°C
Maximum Ambient Temperature	T _A		85	οС

8.0 Mechanical Drawing





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